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Characterization of the detection chain of the Micro-channel X-ray Telescope

Francesco Ceraudo^{a,1,*}, Aline Meuris^a, Eric Doumayrou^a, Luc Dumaye^a,
Alain Goetschy^a, Tony Lavanant^a, Michel Lortholary^a, Isabelle Le Mer^a,
François Nico^a, Frédéric Pinsard^a, Marin Prieur^a, Diana Renaud^a,
Benjamin Schneider^a, Thierry Tourrette^a, François Visticot^a, Norbert
Meidinger^b, Danilo Mießner^c, Diego Götz^a

^a*Astrophysics Division, IRFU, AIM, CEA, CNRS, Université Paris-Saclay, Université
Paris Diderot, Sorbonne Paris Cité, F-91191, Gif-sur-Yvette, France*

^b*Max-Planck-Institut für extraterrestrische Physik, Giessenbachstrasse, 85748 Garching,
Germany*

^c*Halbleiterlabor der Max-Planck Gesellschaft, Otto-Hahn-Ring 6, 81739 München,
Germany*

Abstract

This paper describes the first performance tests and characterization of the detection chain of the Micro-channel X-ray Telescope (MXT), one of the instruments on board the French-Chinese mission SVOM for the study of Gamma-Ray Bursts. The MXT detector consists of a back-illuminated 450 μm -thick fully-depleted frame-store silicon pnCCD, operating in the 0.2 – 10 keV energy range. Featuring an imaging area of $\approx 4 \text{ cm}^2$, the device is read out in parallel by two CAMEX ASICs and is powered and controlled by its dedicated Front-End Electronics. A complete setup based on a cryostat and a multi-energy X-ray source have been designed for the characterization of the detection chain. The tests, performed at $\approx -65 \text{ }^\circ\text{C}$, demonstrate a spectral resolution of $(82 \pm 2) \text{ eV}$ at 1.5 keV as well as a $< 200 \text{ eV}$ low-level threshold. Both of those results are in compliance with the performance requirements of the instrument.

*Corresponding author

Email address: francesco.ceraudo@cea.fr, francesco.ceraudo@inaf.it
(Francesco Ceraudo)

¹Present address: Institute for Space Astrophysics and Planetology, National Institute for Astrophysics, Via del Fosso del Cavaliere 100, 00133, Roma, Italy

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1. Introduction

The *Space-based multi-band astronomical Variable Object Monitor* (SVOM) is a Chinese-French space astronomy mission for the study of Gamma-Ray Bursts (GRBs) and other transient astrophysical phenomena [1]. To be launched at the end of 2021, SVOM will achieve high sensitivity from MeV photons to Near Infra-Red wavelengths. This will allow the detection of all types of GRBs, for which it will provide fast and reliable positions as well as spectral and temporal evolution.

Part of the French contribution to the scientific payload of the satellite, the *Micro-channel X-ray Telescope* or MXT [2], depicted in Fig. 1, will be the first instrument for space astronomy to mount Micro-Pore Optics (MPOs) arranged in a *lobster-eye* configuration. The optics have been developed and built by the University of Leicester, using MPO plates from Photonis France [3]. With a 1.15 m focal length, the telescope will operate in the 0.2 – 10 keV range and feature a 10 arcmin angular resolution along with an effective area of 23 cm² at 1 keV. MXT will have a twofold goal: (1) to provide < 2 arcmin source localization accuracy in less than 10 min for > 90 % of GRBs; (2) to study the afterglow emission with an energy resolution of ~ 80 eV at 1.5 keV.

To ensure its objectives, the focal plane of MXT will be equipped with a 450 μm -thick fully-depleted frame-store Charge-Coupled Device entirely based on pn-junctions (pnCCD). Heritage of XMM/EPIC-pn [4] and provided by the Max Planck Institute for Extraterrestrial Physics (MPE), it was originally developed as one of the earlier detector models for the eROSITA mission [5]. Composed of a matrix of 256×256 75 μm -side pixels, the pnCCD is read out by two CAMEX 128MJD ASICs ($\text{ENC} \approx 2 e_{\text{rms}}^-$) [6, 7]. The device is visible in Fig. 1c.

MXT will be the first experiment to operate a pnCCD in the harsh environment of Low-Earth Orbit. This presents a highly variable thermal radiative background, dominated by periodic occultations and Earth's infrared and albedo emissions. In addition, the orbit features intense particle radiation, due to the fact that the SVOM satellite will cross several times per day the South Atlantic Anomaly, a region with high concentration of protons and electrons trapped in the Earth's magnetic field. The design of MXT is

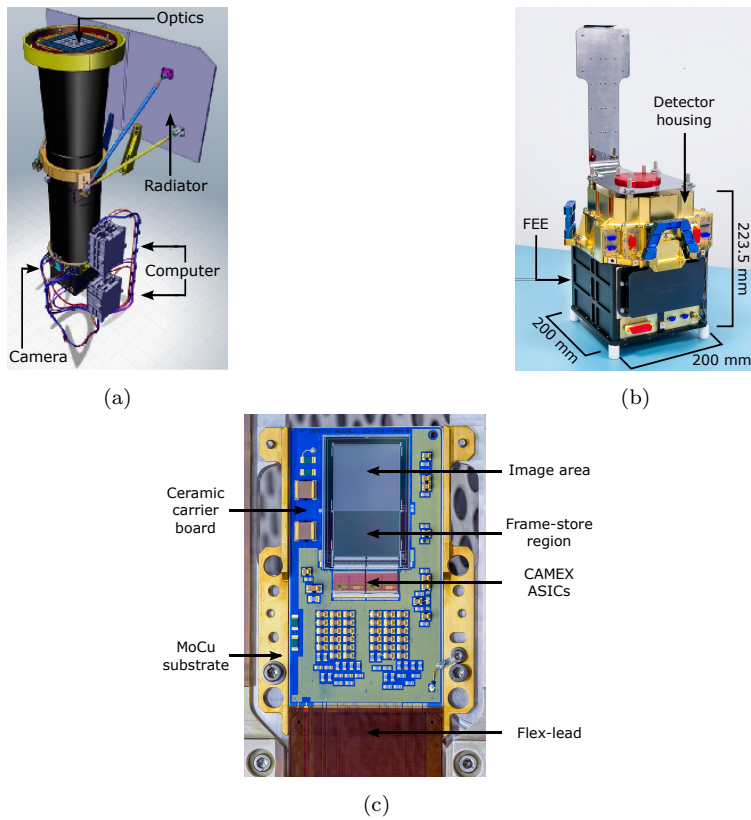


Figure 1: The Micro-channel X-ray Telescope (MXT). a) Overview of the telescope. b) The MXT camera, housing the detector and the Front-End Electronics box. c) Close-up of the front-side of the MXT detector mounted on its carrier board: its working principle and main components are detailed in § 2.

34 further affected by its mass (35 kg) and power (50 W) budgets, very tight
35 when compared to instruments with similar purposes such as SWIFT/XRT,
36 with its mass of ≈ 200 kg [8]. All those constraints force the MXT detector to
37 function at ≈ -65 °C, a far higher temperature than the -90 °C of missions
38 such as XMM/EPIC-pn and eROSITA, both of which use similar pnCCDs.
39 It is therefore mandatory to study the spectral performances of the MXT
40 detector and to verify the compliance with the scientific requirements, i.e.
41 energy resolution of ~ 80 eV at 1.5 keV and low-energy threshold of 200 eV.

42 The following sections present an overview of the working principle of the
43 MXT detector and the subsystems allowing its operation (§ 2). Afterwards,
44 the analysis algorithms of the data of the MXT pnCCD are detailed (§ 3).
45 Finally, the tests and results carried out on the Performance Model of the
46 MXT detector are discussed (§ 4).

47 **2. MXT detection chain**

48 *2.1. The MXT detector*

49 By taking advantage of the principle of sideways depletion [9], the ap-
50 plication of a set of voltages to the electrodes (cathodes) at the front and
51 back sides of the detector allows the silicon bulk of the MXT Charge Cou-
52 pled Device to be depleted over its entire 450 μm -thickness. Full depletion
53 and back-illumination grant the sensor a > 90 % quantum efficiency over the
54 1 – 10 keV range. Featuring a monolithic back-side also ensures a 100 % fill
55 factor. The front-side of the detector is segmented into electrodes (called shift
56 registers or phases) grouped into a matrix of pixels. Two active regions can
57 be identified (whose purpose is defined below): an *image area*, made out of
58 256×256 pixels measuring $75 \mu\text{m} \times 75 \mu\text{m}$ (active area of $19.2 \text{ mm} \times 19.2 \text{ mm}$),
59 and a *frame-store region*, having 256×256 pixels measuring $75 \mu\text{m} \times 51 \mu\text{m}$.

60 *2.2. Acquisition and readout*

61 During the integration phase (lasting $t_{\text{int}} = 100$ ms in MXT), the image
62 region of the detector is exposed to X-rays which enter from the back-side
63 and deposit their energy via photoelectric effect creating electron-hole clouds.
64 While holes are absorbed by the cathodes, electrons migrate to local potential
65 minima under the pixels near the front-side of the pnCCD. The charges thus
66 distributed below the pixels of the matrix collectively make up a *frame*. After
67 integration, periodic changes of the electrical potential of the shift registers
68 allow the charge packets to be moved pixel by pixel towards the bottom of the

69 image area and into the frame-store region, which is shielded against X-rays,
70 where they await readout. The frame shift takes $t_{\text{transf}} = 230 \mu\text{s}$ in MXT,
71 thus reducing the probability of out-time-events² to $t_{\text{int}}/t_{\text{transf}} \approx 0.2\%$. The
72 readout process occurs in 10 ms in a *column-parallel* fashion, meaning that
73 no pixel serialization is present, but each CCD column is provided with its
74 own anode and connected to one input channel of the two CAMEX ASICs
75 (Fig. 1c). Both the pnCCD and the two CAMEX are mounted on an alumina
76 (Al_2O_3) carrier board coupled with a copper-molybdenum (MoCu) substrate
77 and kept at the nominal operating temperature of $\approx -65^\circ\text{C}$ by an active
78 cooling system made out of three Thermo-Electric Coolers (TECs).

79 2.3. Front-End Electronics

80 A warm Front-End Electronics (FEE, Fig. 1b) ensures: (1) power supply
81 of the focal plane and analog-to-digital conversion of the CAMEX output;
82 (2) readout clocks and sequencing; (3) on-line pre-processing for photon ex-
83 traction and communication with the on-board computer (the MXT Data
84 Processing Unit or MDPU). Two modes of operation are possible: (1) in *full-*
85 *frame mode* whole 256×256 -pixel frames exit the FEE without treatment;
86 in *event mode* the FEE output consists of a stream of hit pixels extracted via
87 on-line pre-processing by the electronics itself (algorithms are detailed in § 3).
88 Due to the performance limitations of the ATMEL FPGA on the FEE, the
89 frequency of the Spacewire link is limited to 20 MHz, which requires to slow
90 down the data transfer rate in full frame mode, and is achieved by increasing
91 the integration time to 200 ms (5 frame s^{-1}). On the contrary, in event mode
92 the nominal 100 ms (10 frame s^{-1}) exposure time can be respected, with an
93 output of up to 5000 hit pixels per frame.

94 3. Analysis algorithms

95 Written entirely in Python 3.7, the algorithms for image and spectral
96 analysis follow the same logic as those developed by the MPE for the char-
97 acterization of the eROSITA detector [10]. Nonetheless, the codes have been

²Out-time-events are photons recorded when the charges are being shifted towards the anodes: their arrival positions are not correctly measured and they cause trails in the image along the transfer direction.

98 improved to enhance robustness to outliers and execution speed, most no-
 99 tably via the implementation of a multi-threading mode of execution when-
 100 ever possible.

101 The algorithms require two kinds of frames: *dark frames*, i.e. images in
 102 which the detector has not been exposed to X-rays, and *photon frames* in
 103 which the X-ray source is present. Before energy calibration is performed (to
 104 be described in § 3.3), all data are to be considered in analog-to-digital units
 105 (ADU).

106 Frame reduction is performed completely off line in full-frame mode
 107 (§ 2.3). In event mode, only photon extraction (§ 3.2) is carried out dur-
 108 ing the acquisition and it requires offset (§ 3.1) and threshold (§ 3.2) maps
 109 to be calculated off line and then loaded into the FEE. In every case, the
 110 spectral analysis takes place after all the data have been gathered. As a ref-
 111 erence, in space, both offset and threshold maps will be computed on board
 112 and uploaded by the MXT Data Processing Unit.

113 3.1. Dark frame reduction

114 The voltages of the analog channels of the readout electronics determine
 115 an image-wide offset that must be subtracted³. Given a succession of dark
 116 frames S , so that a pixel at row i and column j on frame k may be identified
 117 as S_{ijk} , the *offset map* O is defined as the pixel-by-pixel median along the
 118 temporal direction:

$$O_{ij} = [S_{ijk}]_k^{50\%}, \quad (1)$$

119 where $[\cdot]_k^{50\%}$ represents the median along the time axis, i.e. frame number,
 120 as frames are acquired sequentially. It is worth noting that the median has
 121 an important advantage over, say, the mean, as it is more robust against
 122 outliers, e.g. cosmic ray traces in the dark frames.

123 Due to the CCD's parallel readout (§ 2.2), fluctuations in the references
 124 of the analog inputs affect all the pixels in a row, while varying from row to
 125 row. This phenomenon is called *common-mode noise* CM and quantified as
 126 the median along each CCD row of an offset-subtracted frame:

$$\text{CM}_{ik} = [S_{ijk} - O_{ij}]_j^{50\%}, \quad (2)$$

³In the case at hand, the leakage current of the detector is so low that its build-up in the CCD pixels is a negligible contribution to the offset when compared to the analog channels.

127 where the notation retains its meaning from eq. (1). It is worth noting
 128 that the common-mode noise is derived separately for the two CAMEX, i.e.
 129 two medians are calculated per row, each one over 128 pixels. Failing to
 130 take this noise source into account may negatively affect the spectroscopic
 131 performances of the detector.

132 After the correction of both offset and common mode, a frame is referred
 133 to as a *flat frame* F :

$$F_{ijk} = S_{ijk} - O_{ij} - \text{CM}_{ik}. \quad (3)$$

134 Finally, the *noise map* N is taken as the pixel-by-pixel difference between
 135 the 84.13%-percentile and the median (which should be zero after all the
 136 corrections) of the distribution of counts along the time axis of a succession
 137 of flat dark frames⁴:

$$N_{ij} = [F_{ijk}]_k^{84.13\% - 50\%}. \quad (4)$$

138 This approach retains the robustness to outliers of the median while at the
 139 same time staying well defined even in case of an asymmetric and/or non-
 140 Gaussian distribution, unlike other estimators such as the standard deviation.

141 3.2. Photon frame reduction

142 Flat photon frames F are obtained by applying eq. (3) to photon frames
 143 S , with the offset map O resulting from the analysis of dark frames and
 144 the common-mode CM from the offset-subtracted photons frames themselves
 145 according to eq. (2). The pixels are then compared to the noise level by
 146 applying a *threshold map* T equal to a multiple of the noise map N , i.e.
 147 $T = nN$. A pixel in position (i, j) on frame k is therefore considered to be
 148 *hit* if

$$F_{ijk} > T_{ij}. \quad (5)$$

149 The value of $n = 4$ is used hereafter, as tests carried out by the MXT team
 150 have verified it ensures the best spectral resolution in the case under study.
 151 This algorithm mimics the operations of the FEE in event mode and is thus
 152 representative within the wider scope of the instrument performances. The
 153 main difference between the two processes is the method by which common-
 154 mode noise is estimated, which is implemented in an approximated form in
 155 the FEE due to performance limitations of the available FPGA.

⁴The values of 84.13% is chosen to match the standard deviation in case of a symmetric Gaussian. Indeed, given a Gaussian distribution of mean μ and standard deviation σ , the integral from $-\infty$ to $\mu + \sigma$ equals 0.8413.

156 As a last step, a pattern-recognition routine groups neighboring pixels
 157 sharing at least one side and classifies them according to the XMM/EPIC
 158 convention for photon and non-photon events (this is done off line regardless
 159 of the mode of operation). As a matter of fact, photons create spherical
 160 charge clouds of dimensions smaller than (but still comparable to) the pixels
 161 and therefore can be collected by up to four pixels arranged in a square, im-
 162 plying that only certain configurations can be accepted as results of photon
 163 interactions. Customarily, photon events are referred to by their multiplic-
 164 ity, i.e. the number of pixels among which the signal is shared, hence one
 165 considers single, double, triple or quadruple events.

166 3.3. Energy calibration

167 Since each CCD column is provided with its own analog channel, energy
 168 calibration must be performed column-wise. Single events are sorted accord-
 169 ing to the readout channel and 256 uncalibrated spectra are thus calculated.
 170 If necessary an additional low-energy threshold (*spectral threshold*) may be
 171 applied to the spectra, a functionality that is found also in the final flight
 172 configuration, where the MDPU can add a second threshold to the one used
 173 for event extraction by the FEE, i.e. the *extraction threshold* of eq. (5).

174 Gaussian profiles are then fitted to some reference peaks of the column-by-
 175 column spectra and a linear calibration is performed for each CCD channel.
 176 Both a gain and an offset are calculated, the second one being supposedly
 177 zero, unless non-linear effects are present.

178 3.4. CTI correction

179 As electron packets are transferred towards the anodes for readout, a
 180 fraction of the charge may be left behind: this phenomenon is described by
 181 the *Charge Transfer Inefficiency* CTI or its complement the *Charge Transfer*
 182 *Efficiency* CTE = 1 – CTI. CTI affects pixels more as the number of transfers
 183 increases. To correct for this effect, after energy calibration, single events
 184 are grouped according to the CCD row and 256 row-by-row spectra are thus
 185 calculated. Line profiles are fitted similarly to the previous case. Here,
 186 however, the centers of the reference lines are then considered as a function
 187 of the number of transfers and the following function is fitted

$$E_n = E_0 \text{CTE}^n, \quad (6)$$

188 where E_n is the line center after n transfers, E_0 is left as a free parameter
 189 and CTE is the Charge Transfer Efficiency. After the estimation of the CTE,

Table 1: Composition of the fluorescence target and corresponding relevant spectral lines. Precise percentages of the materials are not known and optimization of the line intensities is completely empirical.

Element	Spectral line eV	
Al	1486	
Sn	3443	3772
Ti	4509	4932
Cr	5412	5947
Fe	6395	7058
Ni	7472	
Cu	8040	8905

190 the pixel amplitude A_{ij} in ADU or keV may be corrected for this effect by
 191 putting

$$A'_{ij} = \frac{A_{ij}}{\frac{E_0}{E_\gamma} \text{CTE} (E_\gamma)^{n_i}}, \quad (7)$$

192 where n_i is the number of transfers corresponding to the i -th row and E_γ is
 193 the *true* photon energy at which the CTE, which is itself energy dependent,
 194 is calculated.

195 3.5. Iterative approach

196 If the CTI is not properly accounted for, the gain estimation will be
 197 slightly off, which in turn affects the determination of the CTI. This is tack-
 198 led with an iterative approach. ADU values are energy-calibrated and em-
 199 ployed to evaluate the CTE, which is used to correct the original ADU data
 200 and allow for a better calibration. After that, a new *relative* estimate of the
 201 CTE is derived, i.e. from already CTI-corrected data, and used again to
 202 correct the original measurements. The procedure is repeated until a satis-
 203 fying level of precision is reached: in practice a couple of repetitions ensure
 204 that the variation of the fitting parameters between iterations stays below
 205 the uncertainty of the fit.

206 4. Results

207 In the following, the results of the laboratory tests carried out on the
 208 Performance Model of the MXT detector are presented. The device is tested

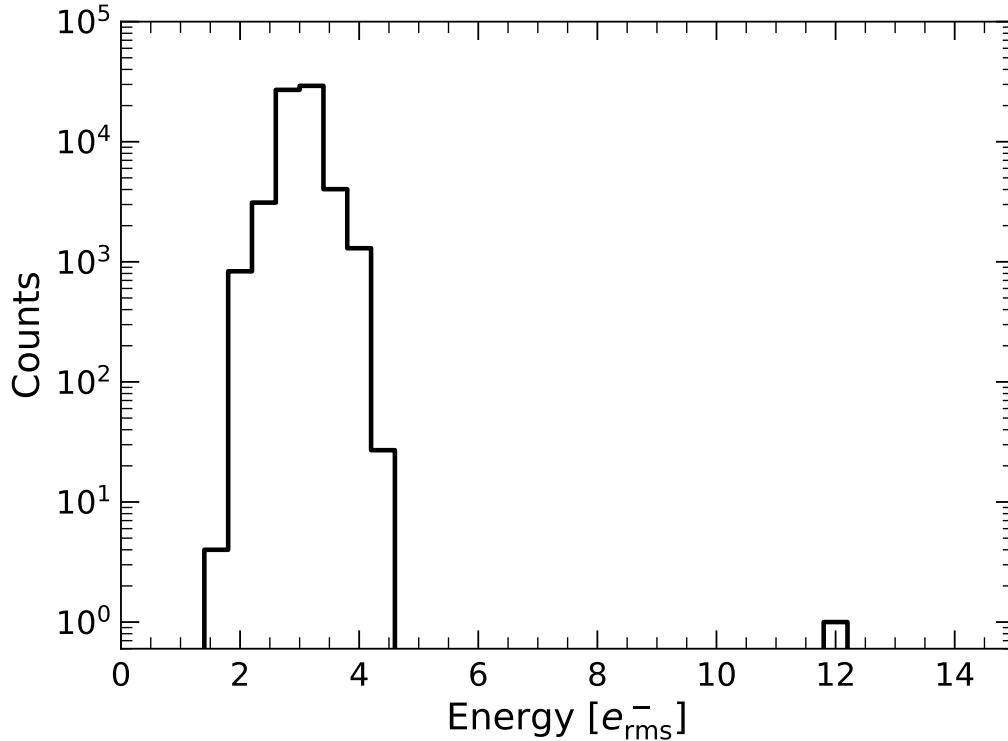


Figure 2: Histogram of the noise values. A median value of $3.25 e_{\text{rms}}^-$ (47 eV) is measured, with 99.73 % (i.e. 3σ -limit) of pixels below $4.10 e_{\text{rms}}^-$ (60 eV). A single noisy pixel is detected.

209 in a dedicated cryostat and photons are generated via an X-ray tube illumi-
 210 nating a composite fluorescent target, whose materials are chosen to generate
 211 a series of spectral lines sampling much of the energy range of operation of
 212 MXT (Tab. 1). A residual Bremsstrahlung emission is also present in the
 213 spectrum.

214 All measurements are taken at a temperature of $\approx -65^\circ\text{C}$, representative
 215 of in-orbit thermal conditions. In line with the flight configuration, the FEE
 216 is kept at room temperature outside the cryostat. Both full-frame and event
 217 modes of operation are tested and, unless otherwise specified, the following
 218 considerations and comments apply to both.

219 *4.1. Noise*

220 Fig. 2 shows the histogram of the pixels of the noise map. The noise is
221 uniform across the detector with a median of $3.2 e_{\text{rms}}^-$ and 99.73% (i.e. 3σ -
222 limit) of pixels below $4.1 e_{\text{rms}}^-$. A single isolated bright spot near the center
223 of the CCD is measured, whose associated noise is $12.3 e_{\text{rms}}^-$. This is likely
224 due to a defect on the detector itself and can be safely flagged and ignored
225 in the analysis.

226 If the spectral calibration of the chain is considered (to be discussed
227 below), the figures above translate to an average pixel-by-pixel threshold of
228 47 eV, with a 99.73% upper limit at ≈ 60 eV. This is fully compatible with
229 the 200 eV requirement on the low-energy threshold of MXT.

230 *4.2. Intensity map*

231 Fig. 3 shows the cumulative map of the photons detected over 2000 frames
232 over the entire energy range generated by the X-ray tube. The response is
233 uniform across the whole detector.

234 *4.3. Energy resolution*

235 Examples of the detector-wide spectra obtained using single events, dou-
236 ble events whichever the orientation, and all events regardless of the multi-
237 plicity are shown in Fig. 4.

238 To calibrate single-event spectra, a model consisting of five Gaussian line
239 profiles and a fourth-degree polynomial continuum is fitted on each column-
240 wise and row-wise spectrum. This allows to achieve better estimation of both
241 line centers and widths by taking into account deformations resulting from
242 the continuous Bremsstrahlung emission of the X-ray generator.

243 Higher multiplicity spectra are calibrated and corrected by using CTI and
244 spectral gain and offset estimated from single events. The spectra are then
245 shifted by an energy-independent offset to align them with respect to the
246 spectrum of single events. This procedure is performed to compensate for a
247 multiplicity-dependent energy shift already observed in XMM/EPIC-pn and
248 similarly addressed [11]. Applying the shift allows to improve the energy
249 resolution of the spectrum of all events by $\approx 20\%$, so that the dominant re-
250 maining noise contribution is electronic noise. This approach to calibration
251 is preferred to employing the same algorithm used for singles to all multi-
252 plicities because it entails a smaller number of calibration parameters, i.e.
253 energy-dependent CTE, 256 column-wise gains, 256 column-wise offsets and

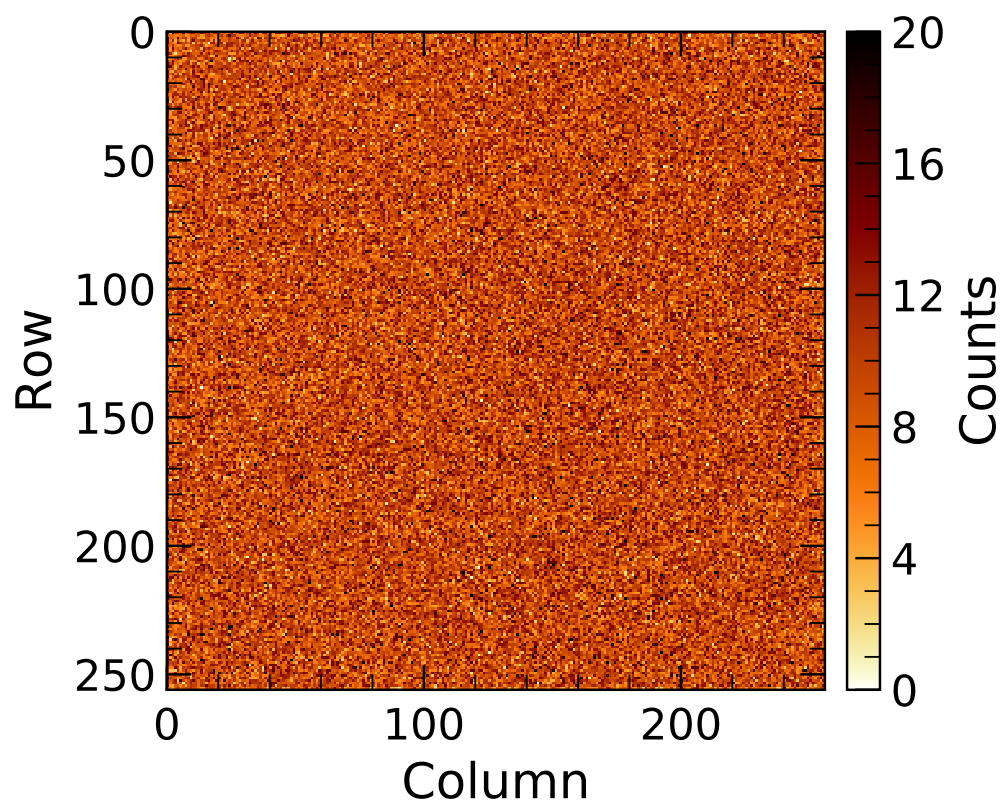


Figure 3: Cumulative map of the photons detected over 2000 frames. The response appear to be uniform across the device.

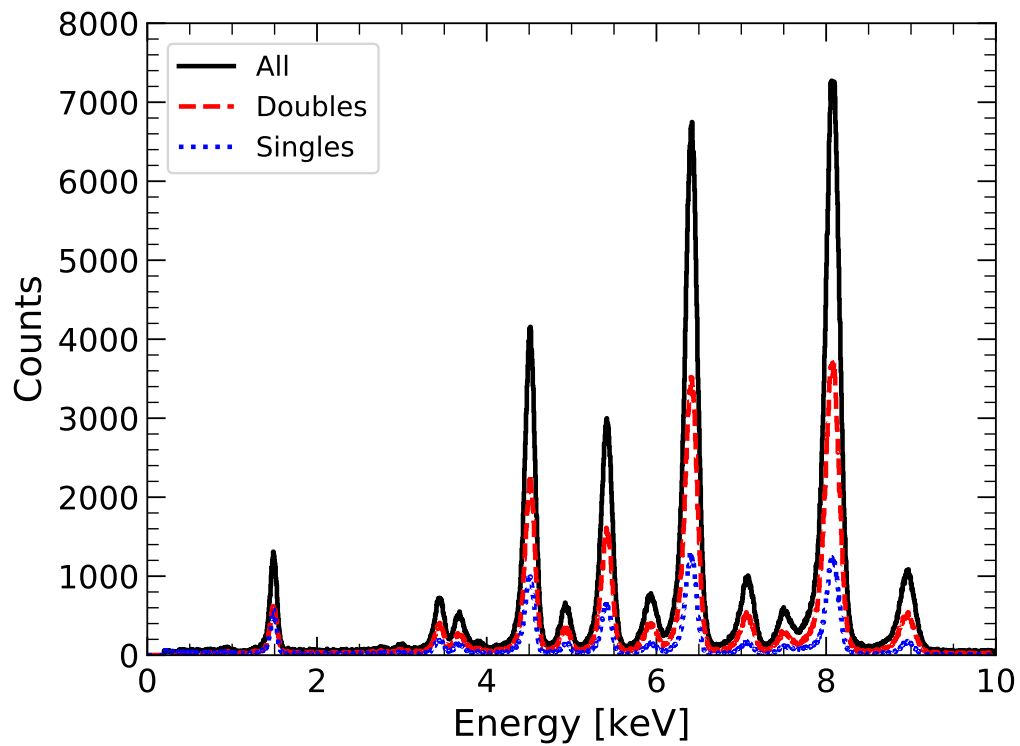


Figure 4: Spectrum of single, double and all events. The reader is referred to Tab. 1 for an identification of the spectral features, and to Tab. 2 and 3 for the values of the spectral resolution at the five most prominent lines.

Table 2: Measured energy resolution for single and all events in full-frame mode.

Line	Energy eV	FWHM eV	
		Singles	All
Al-K $_{\alpha}$	1486	82 ± 2	91 ± 1
Ti-K $_{\alpha}$	4509	116 ± 1	134 ± 2
Cr-K $_{\alpha}$	5412	118 ± 6	142 ± 4
Fe-K $_{\alpha}$	6395	145 ± 1	164 ± 3
Cu-K $_{\alpha}$	8040	173 ± 1	193 ± 1

Table 3: Measured energy resolution for single and all events in event mode.

Line	Energy eV	FWHM eV	
		Singles	All
Al-K $_{\alpha}$	1486	91 ± 3	103 ± 3
Ti-K $_{\alpha}$	4509	142 ± 16	146 ± 2
Cr-K $_{\alpha}$	5412	142 ± 15	154 ± 2
Fe-K $_{\alpha}$	6395	151 ± 2	176 ± 2
Cu-K $_{\alpha}$	8040	176 ± 2	199 ± 1

254 4 energy shifts compared to energy-dependent CTE, 256 column-wise gains
 255 and 256 column-wise offsets per multiplicity.

256 In all cases, a 200 eV spectral threshold is imposed to the photon events,
 257 i.e. reconstructed patterns.

258 The Full Width at Half Maximum (FWHM) of the five most prominent
 259 lines are reported in Tab. 2 for full-frame operation and Tab. 3 for event
 260 mode. In the former case, results are compatible with the spectral energy
 261 resolution requirement of 80 eV at 1486 eV at the beginning of the mission. In
 262 the latter scenario, the compliance is missed and improvements are ongoing
 263 to achieve a better agreement with the mission requirements. Indeed, the
 264 mismatch of the spectral performances between the two modes of operation
 265 likely results from the different implementation of the common-mode noise
 266 correction algorithm in the FEE, as anticipated in § 3.1 and § 3.2.

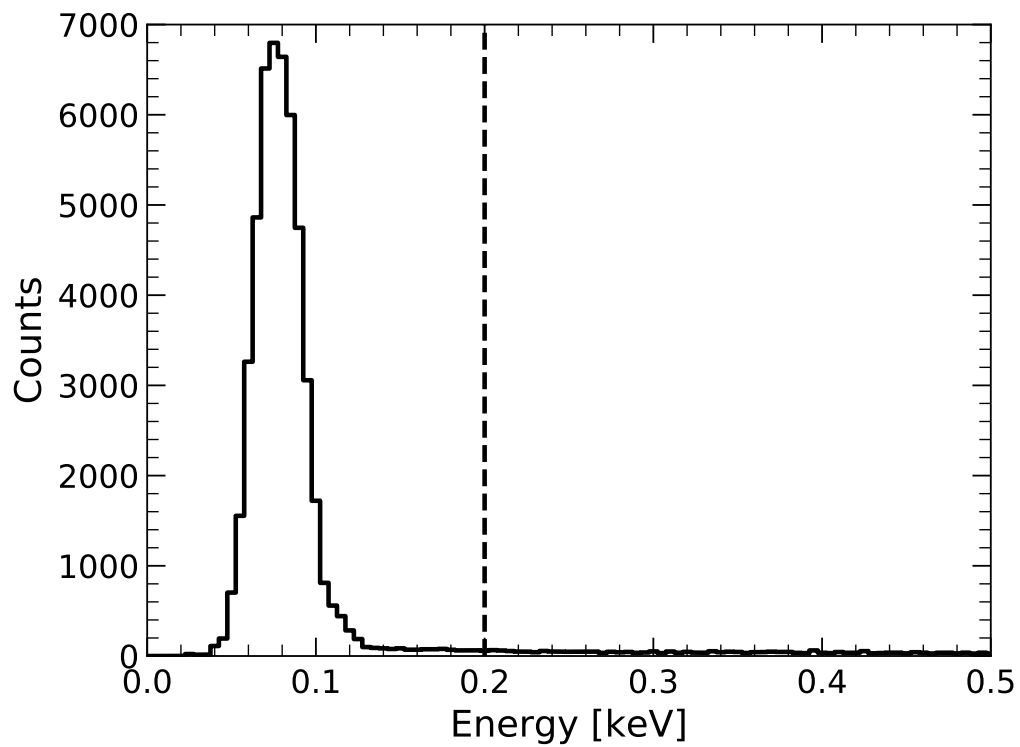


Figure 5: Low-energy portion of the single-event spectrum of Fig. 4 in case no spectral threshold is imposed. The $T = nN$ extraction threshold (with $n = 4$) of § 3.2 is still present as necessary to identify hit pixels. The instrument specification at 200 eV is marked by a dashed line.

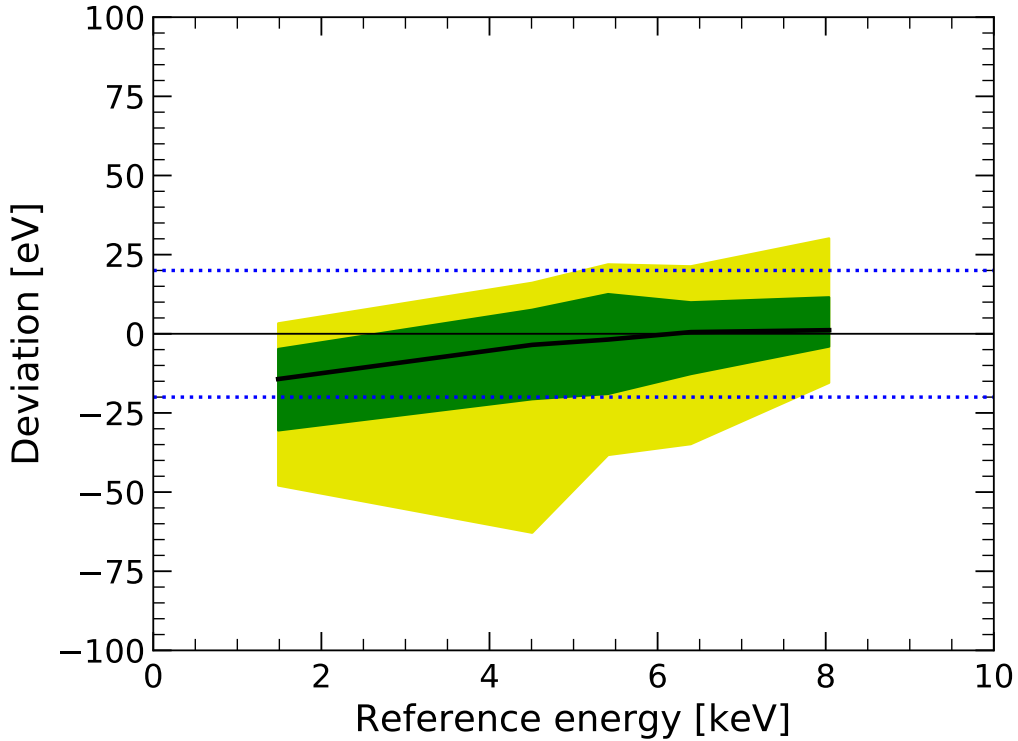


Figure 6: Distribution of the energy shifts across the columns at each reference energy. The solid black curve represents the median, while the inner (respectively outer) region indicates where 68% (respectively 95%) of the results lie. The dotted lines mark the ± 20 eV interval.

267 *4.4. Low-level threshold*

268 Fig. 5 shows the < 500 eV portion of the detector-wide spectrum obtained
 269 using only single events (dotted curve of Fig. 4). Contrary to Fig. 4, in this
 270 case the 200 eV spectral threshold is not imposed and only the extraction
 271 threshold used for the identification of hit pixels (§ 3.2) is applied. The
 272 low-energy noise peak arises from spurious counts having energies above the
 273 extraction threshold, i.e. 4 times the noise level estimated from the analysis
 274 of dark frames (§ 3.2 and § 4.1). The instrument specifications require a low-
 275 energy (spectral) threshold of 200 eV, marked in Fig. 5: this is fully achieved
 276 in the case under analysis both in full-frame mode and in event mode, as the
 277 noise peak extends up to ≈ 130 eV.

Table 4: Measured Charge Transfer Inefficiency.

Line	Energy eV	CTI $\times 10^{-5}$
Al-K $_{\alpha}$	1486	2.3 ± 0.8
Ti-K $_{\alpha}$	4509	1.3 ± 0.2
Cr-K $_{\alpha}$	5412	1.5 ± 0.2
Fe-K $_{\alpha}$	6395	1.2 ± 0.1
Cu-K $_{\alpha}$	8040	1.0 ± 0.1

278 *4.5. Non-linearity*

279 Fig. 6 shows the distribution across all columns of the deviations of the
 280 fitted line centers of the five main spectral lines from their respective ref-
 281 erence energies. Median shifts are always between ± 20 eV from zero and
 282 68 % of cases are always within ± 30 eV. The spread of the deviations around
 283 the median is also energy-dependent, with absolute shifts reaching 70 eV for
 284 energies around 4.5 keV.

285 This phenomenon is likely to be the consequence of a small channel-
 286 dependent non-linear response of the readout electronics. As the analysis
 287 algorithms are based on a linear spectral calibration, the aforementioned
 288 deviations are currently unavoidable and further studies are necessary to
 289 mitigate this effect, in relation to the requirement of < 20 eV-variations of
 290 the energy scale across the whole detector.

291 *4.6. Charge Transfer Inefficiency*

292 Estimates of the Charge Transfer Inefficiency at the five main spectral
 293 lines are presented in Tab. 4. The results are in agreement with the literature
 294 [5], where a value of $\text{CTI}(6 \text{ keV}) = 10^{-5}$ is reported.

295 **5. Summary and conclusions**

296 This paper reports on the first performance tests and characterization of
 297 the detection chain of the Micro-channel X-ray Telescope on board the SVOM
 298 mission. Despite the higher operating temperature (≈ -65 °C according to
 299 the mission baseline) that sets MXT apart from previous missions mounting
 300 similar detectors, we demonstrate an energy resolution of 82 eV at 1.49 keV
 301 on the sum spectrum built with single events in full-frame mode, as well as

302 a < 200 eV low-energy threshold, all of which show the compliance of the
303 measurements taken in full-frame mode with the performance requirements
304 of the instrument. Further optimization is required to decrease the mismatch
305 between the results taken in full-frame and event modes, in order to bring the
306 latter closer to the mission specifications. A similar care must be dedicated
307 to the energy scale of the detector, both from a software and from a hardware
308 point of view, in order to reduced the measured deviations.

309 The detector studied in this paper is currently integrated in a camera to
310 be mounted on the Performance Model of the whole telescope for end-to-end
311 tests at the PANTER X-ray facility.

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